

30V N-Channel MOSFETS

TO-252 Pin Configuration

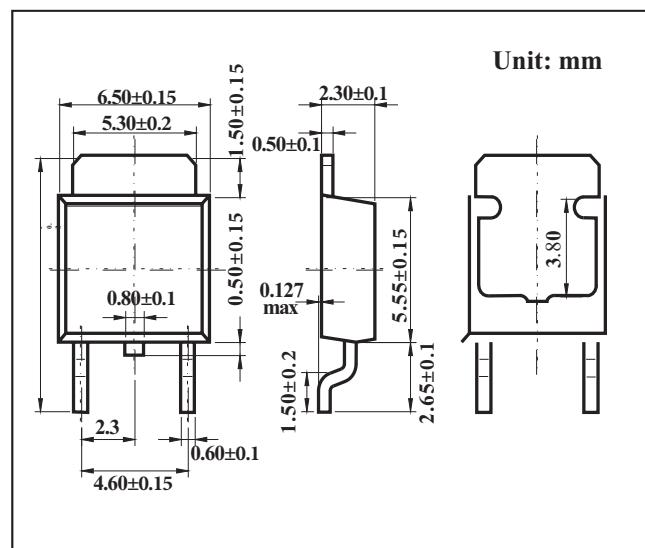
BVDSS	RDS(ON)	ID
30V	6mΩ	80A

FEATURES

- 30V, 80A, RDS(ON) = 6mΩ@VGS = 10V
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

APPLICATIONS

- MB / VGA / Vcore
- POL Applications
- SMPS 2nd SR



MAXIMUM RATINGS AND CHARACTERISTICS

@ 25°C Ambient Temperature (unless otherwise noted)

Parameter	Symbol	Rating	Units
Drain-Source Voltage	VDS	30	V
Gate-Source Voltage	VGS	±20	V
Drain Current – Continuous (TC=25°C)	ID	80	A
Drain Current – Continuous (TC=100°C)		51	A
Drain Current – Pulsed ¹	IDM	320	A
Single Pulse Avalanche Energy ²	EAS	88	mJ
Single Pulse Avalanche Current ²	IAS	42	A
Power Dissipation (TC=25°C)	PD	54	W
Power Dissipation – Derate above 25°C		0.43	W/°C
Storage Temperature Range	TSTG	-55 to +150	°C
Operating Junction Temperature Range	TJ	-55 to +150	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance Junction to ambient	R _{θJA}	---	62	°C/W
Thermal Resistance Junction to Case	R _{θJC}	---	2.3	°C/W

MOSFET ELECTRICAL CHARACTERISTICS $T_A=25^\circ\text{C}$ unless otherwise specified

Off Characteristics

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}$, $I_D=250\mu\text{A}$	30	---	---	V
BV_{DSS} Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Reference to 25°C , $I_D=1\text{mA}$	---	0.04	---	
Drain-Source Leakage Current	I_{DSS}	$V_{\text{DS}}=30\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	1	μA
		$V_{\text{DS}}=24\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=125^\circ\text{C}$	---	---	10	μA
Gate-Source Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 100	nA
Static Drain-Source On-Resistance ³	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}$, $I_D=20\text{A}$	---	4.8	6	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}$, $I_D=10\text{A}$	---	6.5	9	$\text{m}\Omega$
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}}=V_{\text{DS}}$, $I_D=250\mu\text{A}$	1	1.6	2.5	V
$V_{\text{GS}(\text{th})}$ Temperature Coefficient	$\Delta V_{\text{GS}(\text{th})}$		---	-4	---	$\text{mV}/^\circ\text{C}$
Forward Transconductance	g_{fs}	$V_{\text{DS}}=10\text{V}$, $I_D=10\text{A}$	---	18	---	S

Dynamic Characteristics

Total Gate Charge ^{3,4}	Q_g	$V_{\text{DS}}=15\text{V}$, $V_{\text{GS}}=4.5\text{V}$, $I_D=20\text{A}$	---	11.1	---	nC
Gate-Source Charge ^{3,4}	Q_{gs}		---	1.85	---	
Gate-Drain Charge ^{3,4}	Q_{gd}		---	6.8	---	
Turn-On Delay Time ^{3,4}	$T_{\text{d}(\text{on})}$	$V_{\text{DD}}=15\text{V}$, $V_{\text{GS}}=10\text{V}$, $R_G=3.3\Omega$, $I_D=15\text{A}$	---	7.5	---	ns
Rise Time ^{3,4}	T_r		---	14.5	---	
Turn-Off Delay Time ^{3,4}	$T_{\text{d}(\text{off})}$		---	35.2	---	
Fall Time ^{3,4}	T_f		---	9.6	---	
Input Capacitance	C_{iss}		---	1160	---	
Output Capacitance	C_{oss}	$V_{\text{DS}}=25\text{V}$, $V_{\text{GS}}=0\text{V}$, $F=1\text{MHz}$	---	200	---	pF
Reverse Transfer Capacitance	C_{rss}		---	180	---	
Gate resistance	R_g		$V_{\text{GS}}=0\text{V}$, $V_{\text{DS}}=0\text{V}$, $F=1\text{MHz}$	---	2.5	---

Guaranteed Avalanche Energy

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Single Pulse Avalanche Energy	EAS	$V_{\text{DD}}=25\text{V}$, $L=0.1\text{mH}$, $I_{\text{AS}}=20\text{A}$	20	---	---	mJ

Drain-Source Diode Characteristics

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	I_s	$V_G=V_D=0\text{V}$, Force Current	---	---	80	A
Pulsed Source Current ³	I_{SM}		---	---	320	A
Diode Forward Voltage ³	V_{SD}	$V_{\text{GS}}=0\text{V}$, $I_s=1\text{A}$, $T_J=25^\circ\text{C}$	---	---	1	V
Reverse Recovery Time	t_{rr}		---	---	---	ns
Reverse Recovery Charge	Q_{rr}	$T_J=25^\circ\text{C}$	---	---	---	nC

Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. $V_{\text{DD}}=25\text{V}$, $V_{\text{GS}}=10\text{V}$, $L=0.1\text{mH}$, $I_{\text{AS}}=42\text{A}$, $R_g=25\Omega$, Starting $T_J=25^\circ\text{C}$.
3. The data tested by pulsed , pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.
4. Essentially independent of operating temperature.

RATINGS AND CHARACTERISTIC CURVES

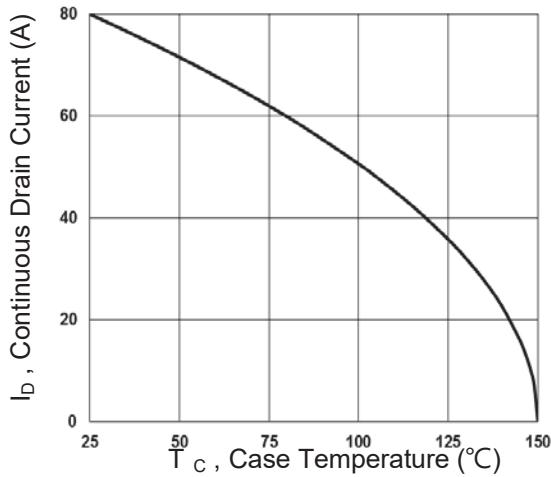


Fig.1 Continuous Drain Current vs. T_c

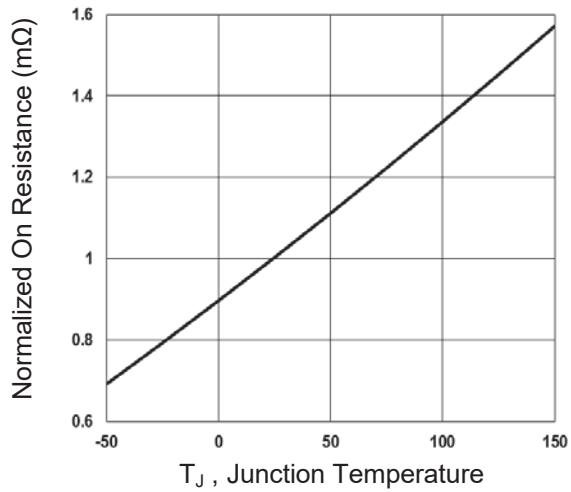


Fig.2 Normalized $R_{DS(on)}$ vs. T_j

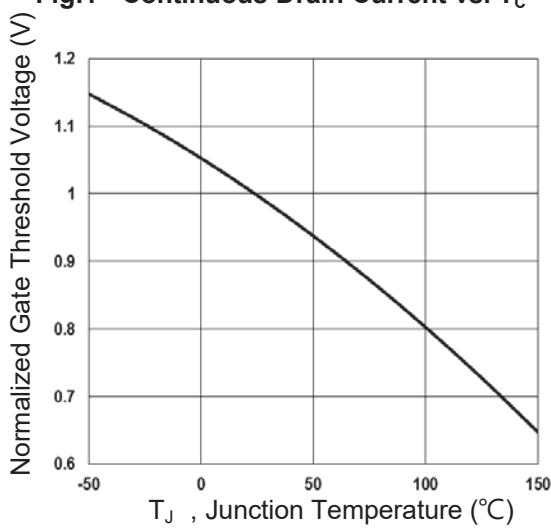


Fig.3 Normalized V_{th} vs. T_j

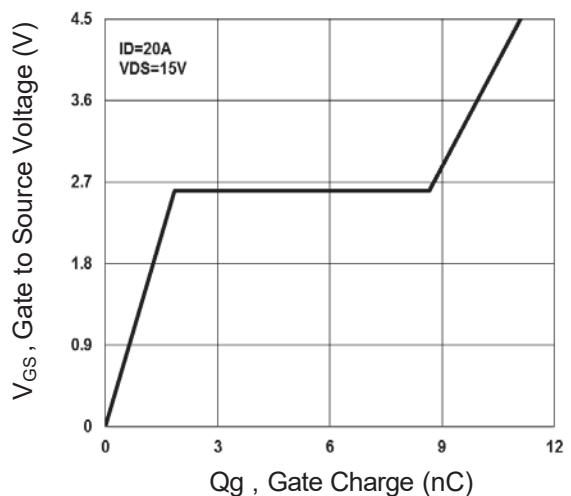


Fig.4 Gate Charge Waveform

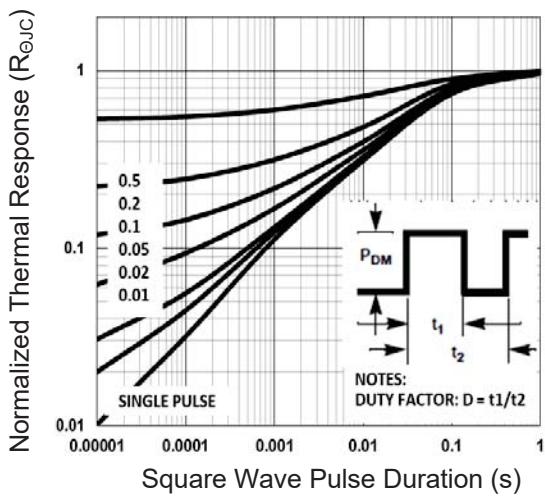


Fig.5 Normalized Transient Impedance

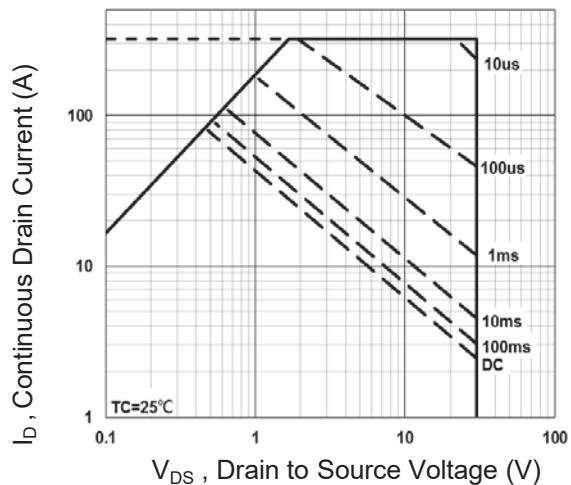


Fig.6 Maximum Safe Operation Area

RATINGS AND CHARACTERISTIC CURVES

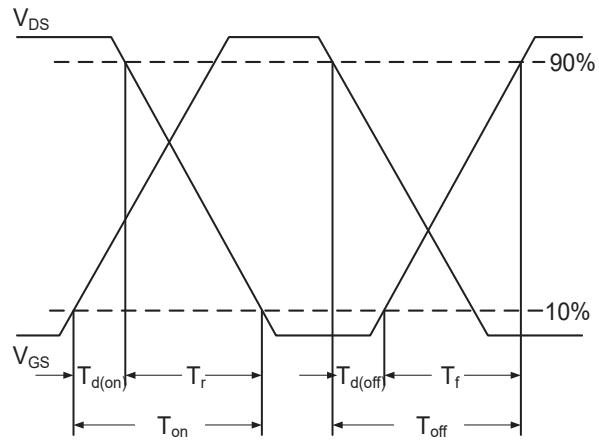


Fig.7 Switching Time Waveform

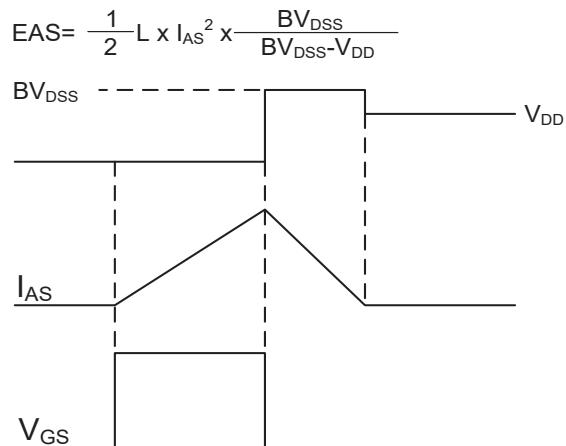


Fig.8 EAS Waveform